



#### EMVA 1288 Standard for Measurement and Presentation of Specifications for Machine Vision Sensors and Cameras

# Clear definitions for a clear VISION



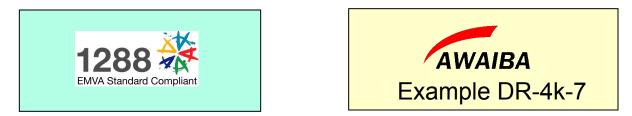
CMOS IMAGE SENSORS

M. Wäny www.awaiba

#### Agenda



- Why we need EMVA 1288 Standard
- o EMVA 1288 Standard organization
- o Measurement setup
- o 1288 Module 1 "in 12 Slides"



o Interpretation of the standard for the user

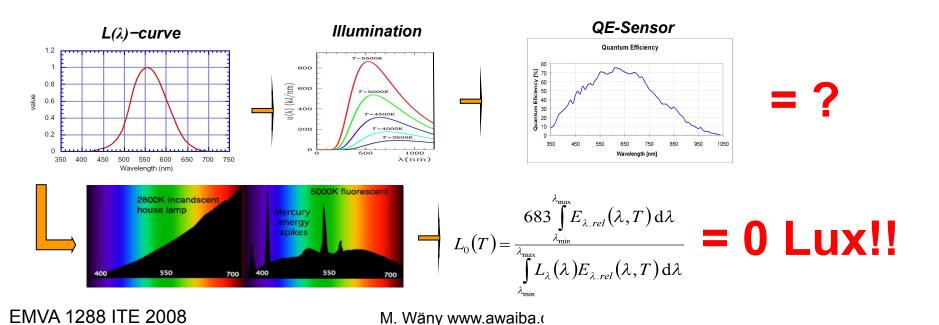


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#### Motivation



- o Existing Standards for cameras are not suitable for MV
- Each Sensor and Camera Manufacturer has it's own definitions
- The Customer is left guessing with datasheets
  - Today cameras and sensor are digital but manufacturers specify V/lux s ?!
  - Lux is a unit adapted vor human vision not for wider spectral band



| The EMVA<br>Group      | <b>1288 Working</b><br>(logos status 2007) | european machine vision association |
|------------------------|--|-------------------------------------|
| Adimec                 | a·s·e·n·t·i·c·s<br>vision technology       | aspect                              |
| <b>AIMEL</b> ®         | AWAIBA                                     | BASLER 7                            |
| DALSA                  | Imaging Development Systems                | <i>j</i> Aj <sup>®</sup>            |
| <b>pco.</b><br>imaging | SONY                                       | STEMMER <sup>®</sup><br>IMAGING     |
|                        | RUPRECHT-KARLS-UNIVERSITÄT<br>HEIDELBERG   | Universität OLDENBURG               |
| BOSCH                  | Melexis                                    |                                     |

#### The EMVA 1288 Working group is open! Contact info@emva.org



#### **Current status**



- Standard Release 2.0
  - Covers Sensitivity Spatial and Temporal Noise; Linearity
  - Adapted by many companies in Europe and World wide for internal use and on customer request.
  - Published data on <u>www.standard1288.org</u> from
    - AWAIBA
    - BASLER
    - PCO

Supported world wide by agreement between JIIA, AIA & EMVA on G3 standardization frame work

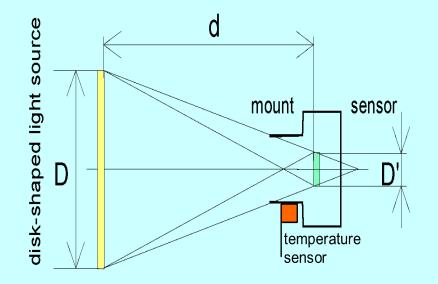


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#### Standard 1288 Module 1 1) Measurement Setup Standard requirements

- o Illumination Setup from Module 1
  - Homogenous illumination
  - Without lens
  - □ F-number 8
  - Definition of temperature measurements

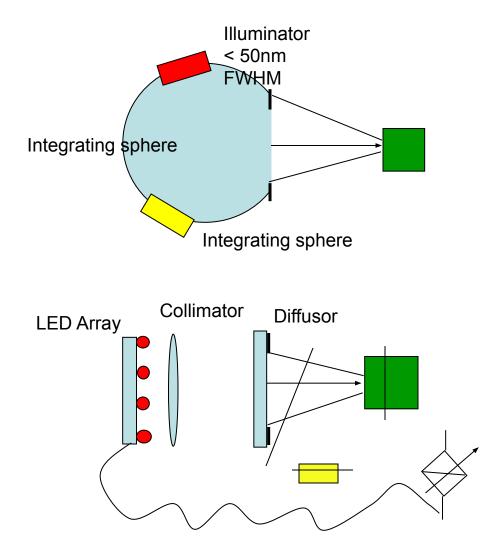




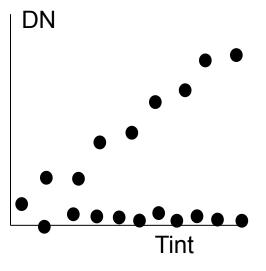


#### Possible realizations of set up





Module 1 measurement

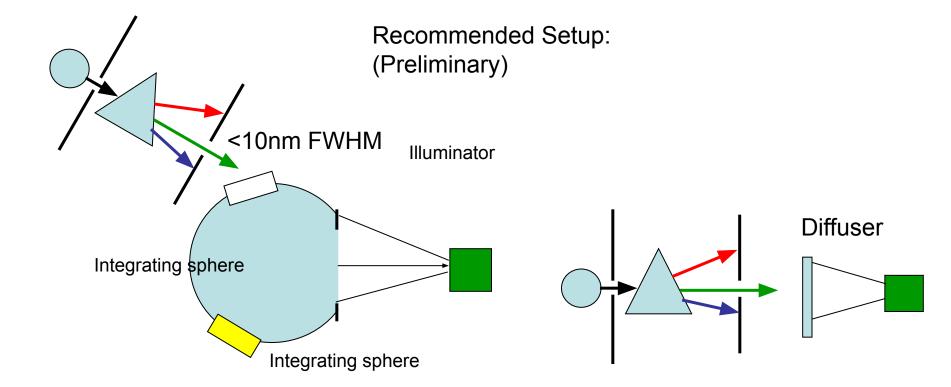




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## Outlook measurement setup variation for Color module



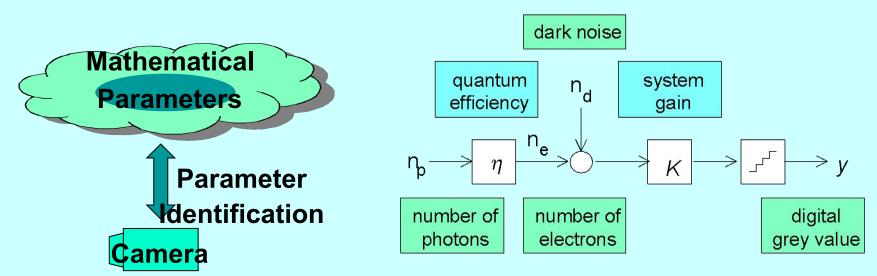




#### Standard 1288 Module 1 2) Mathematical Model



### ! The standard will only produce sense full results for cameras / sensors that follow the mathematical model !



**Current module covers only linear integrating sensors** 

#### More sensor types to follow

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#### Standard 1288 Module 1 3) Basic Information



This section delivers general information and information regarding the operation point at which data is acquired.

- Vendor name
- Model name
- **Type of data presented:** Typical; Guaranteed; Guaranteed over life time[1]
- Sensor type (CCD; CMOS; CID etc...)
- Sensor diagonal in [mm]; Indication of lens category to be used [inch]
- **Resolution; Pixel size** (width x height in [µm])
- Readout type (CCD only) ; Transfer type (CCD only);
- Shutter type (CMOS only); Global; Rolling
- **Overlap capabilities; (**readout of frame *n* and exposure of frame *n*+1 can happen at the same time).
- Maximum **frame rate** at the given operation point. (no change of settings permitted)
- Others (Interface Type etc..)



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| Vendor Name   | AWAIBA Lda   |
|---|--|
| Model Name  | DR-4k-7  |
| Sensor Type   | CMOS Digital Line Scan Sensor                                      |
| Sensor diagonal in mm   | 28.67mm  |
| Indication lens category (inch)   |  |
| Resolution ( width x height)  | 4096 x 1   |
| Pixel size  | 7um x 7um  |
| Readout type  | 4 Tap 40MHz 12bit parallel   |
| Shutter type ( Rolling/ Global)   | Global Shutter   |
| Overlap capabilities (Integration overlaps Readout)                     | Interleaved integration & Readout                                  |
| Maximum frame rate at given operation point                             | 9765 lines / second<br>(40k lines / sec @ maximum operation point) |
| Type of presented data (typical /guaranteed/ guaranteed over live time) | typical  |
| Definition of "typical" (number of samples etc)                         | 1 random sample  |
| Other relevant information (interface type etc)                         | 12 bit digital parallel  |
| Photodiode type (see QE plot)   | Standard diode   |



#### Standard 1288 Module 1 4) Operation Point



- This section describes exactly in what configuration the camera / Sensor is operated.
   I.e. all gain & register settings and environmental conditions.
- Unless for the scans of the integration time, the camera / sensor has to be in the same operation point for all EMVA1288 measurements.



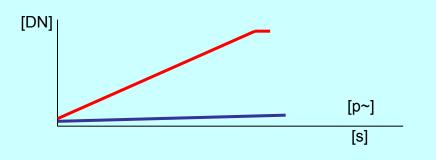
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| Main Clock Frequency           | 40MHz    |
|--------------------------------|----------|
| Line Period                    | 205 us   |
| ADC End Range Register         | 0x84     |
| Illumination Wavelength        | 625nm    |
| On chip ADC offset subtraction | Enabled  |
| Config. Register 1             | 00100001 |
| Config. Register 2             | 00110000 |
| ADC Gain                       | 0x20h    |

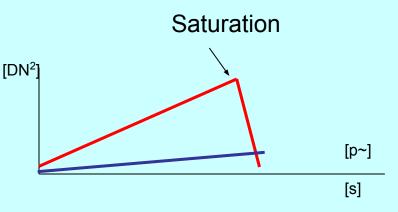


#### Standard 1288 Module 1 5) Measurement Scans



Acquire 2 series of images with increasing Exposure time. One series in dark, one with a constant illumination. Compute the mean value of The images, report the mean versus the integration time and the number of photons Collected in each pixel.



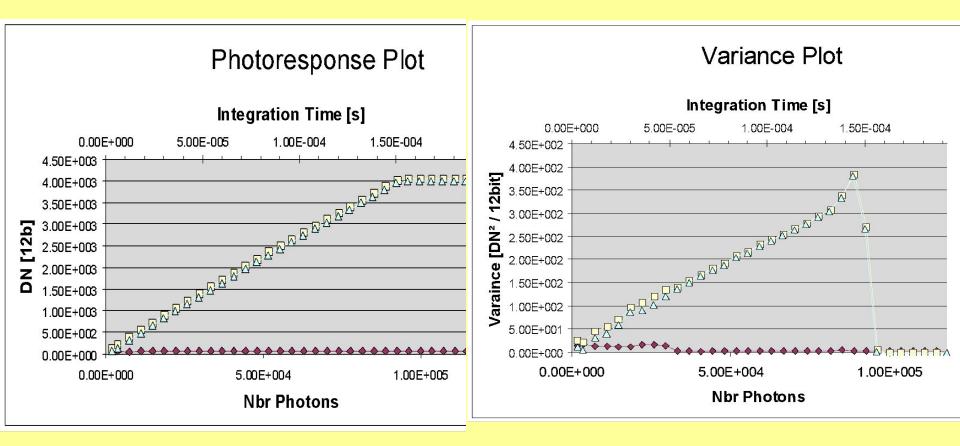


From 2 images at the same integration time, compute the square difference image. The mean of the squared difference image is the Variance. Report the variance for the series in dark and for the series with light versus integration time and number of photons. Saturation exposure is defined as the exposure where the variance is maximal



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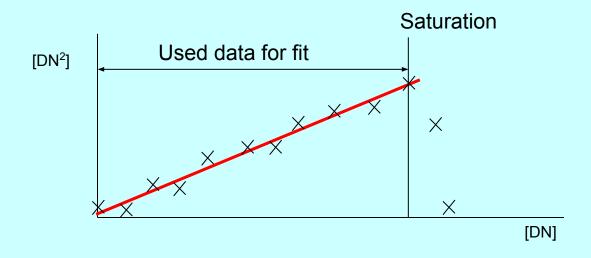






#### Standard 1288 Module 1 6) Photon Transfer Method





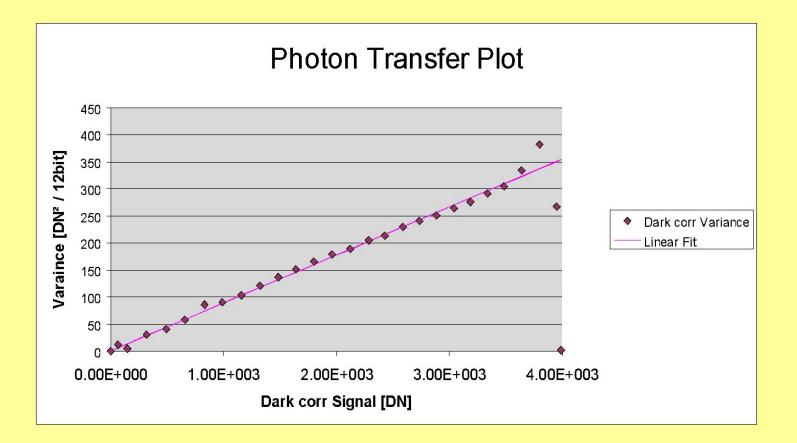
Subtract the mean dark values from the mean values with illumination.
Subtract the dark variance values form the bright variance values.
Report the dark corrected variance versus the dark corrected mean values.
Fit a line going through the origin through the data points until saturation
The slope of this line gives the conversion gain in DN/e- or K



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#### Standard 1288 Module 1 7) Derived Quantities



| Quantity   | Value |
|--|-------|
|  | value |
| $\eta(\lambda)$ : Total quantum efficiency in [%] at measurement wavelength  |       |
| $\sigma_{d0}$ : Standard deviation of the <b>temporal dark noise</b> referenced to electrons for exposure time zero in [e-]. |       |
| $N_{d30}$ : Dark current for a housing temperature of 30°C in [e-/s].  |       |
| $\frac{1}{K}$ : Inverse of overall system gain in [e-/DN].   |       |
| $\mu_{e,sat}$ : Saturation capacity referenced to electrons in [e-].   |       |
| $\mu_{p,\min}(\lambda)$ : Absolute sensitivity threshold in [p~] at the measurement  |       |
| wavelength   |       |
| $SNR_{y}(\mu_{p})$ : Signal to noise ratio at saturation   |       |
| DYN <sub>in</sub> = DYN <sub>out</sub> : <b>Dynamic range in [1]</b>   |       |
| DSNU <sub>1288</sub>   |       |
| PRNU <sub>1288</sub>   |       |
| $\sigma_o$ : Standard deviation of the spatial offset noise referenced to  |       |
| electrons in [e-]  |       |
| $S_g$ : Standard deviation of the spatial gain noise in [%].   |       |



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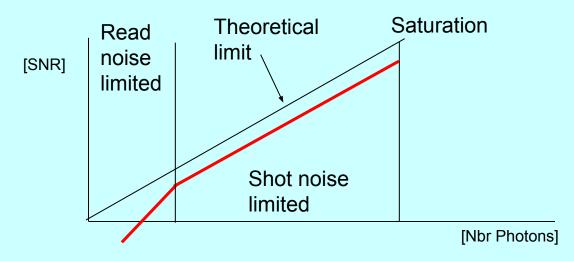
european machine vision association

| Parameter   | Value  |
|---|--------|
| Conversion Gain [DN/e-]                           | 0.0886 |
| QE*   | 49.58% |
| Saturation capacity [e-]                          | 47'737 |
| Responsivity [DN/nJ/cm2]**                        | 67.9   |
| Temporal dark noise [DN]                          | 1.1    |
| Temporal dark noise [e-]                          | 12.9   |
| Absolute sensitivity threshold [p/pix]            | 26     |
| SNR emva1288                                      | 193    |
| SNR emva1288[dB]                                  | 46     |
| DYN (standard SNR)                                | 1972   |
| DYN [dB] (standard SNR in dB)                     | 65.9   |
| DSNU 1288 [e-]                                    | 13.4   |
| DSNU [DN] (standard deviation of mean dark image) | 1.4    |
| PRNU 1288   | 1.9%   |
| Dark Current 30C [e-/ms]                          | 3      |
| Dark current doubling temperature [C]             | 11.5   |



#### Standard 1288 Module 1 8) SNR Plot





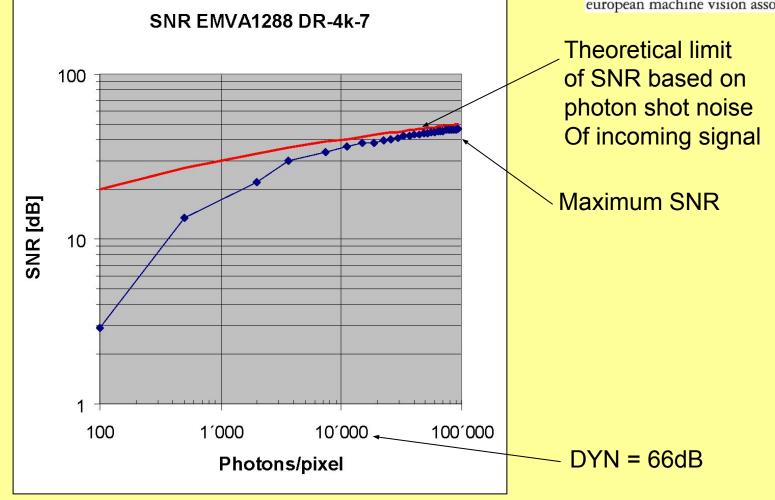
Plot the SNR values resulting from each integration time versus the number of photons impinging on a pixel during this integration time.
Use Logarithmic scale (dB or bit (base log2)
Plot values from lowest chosen integration time til saturation.



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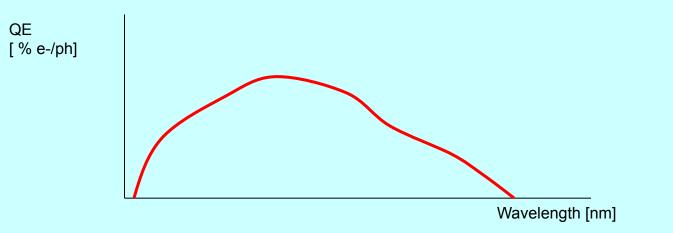




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#### Standard 1288 Module 1 9) Quantum Efficiency Plot



oFrom the conversion gain and the light intensity used during exposure compute the total QE.

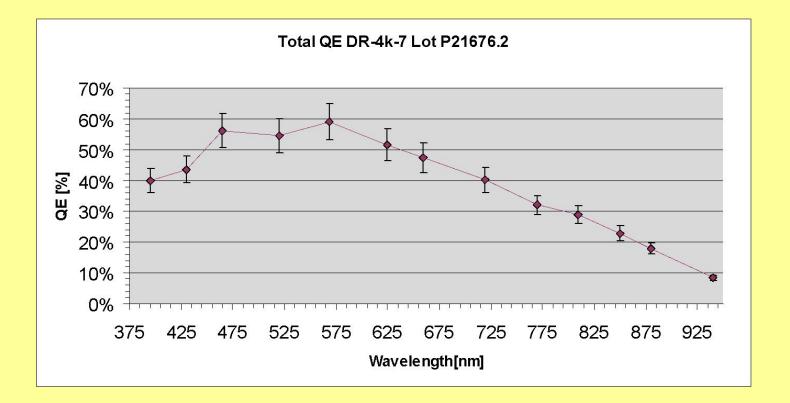
oReport the QE versus measurement wavelengths.

 Note for EMVA1288 data given per unit: When clearly stated this measurement can be based on typical data even for production data, however the curve should be scaled to the QE measured at the specific measurement wavelength of sample.



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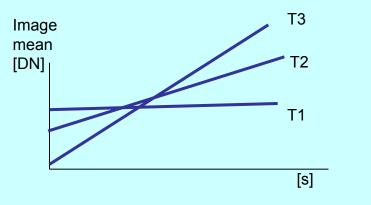




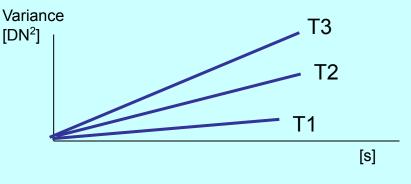
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Standard 1288 Module 1 10) Dark Current



## european machine vision association



Acquire series of dark images versus increasing integration times at different housing temperatures.
(Measurement not applicable for cooled cameras)
Report the increased signal values versus integration time.

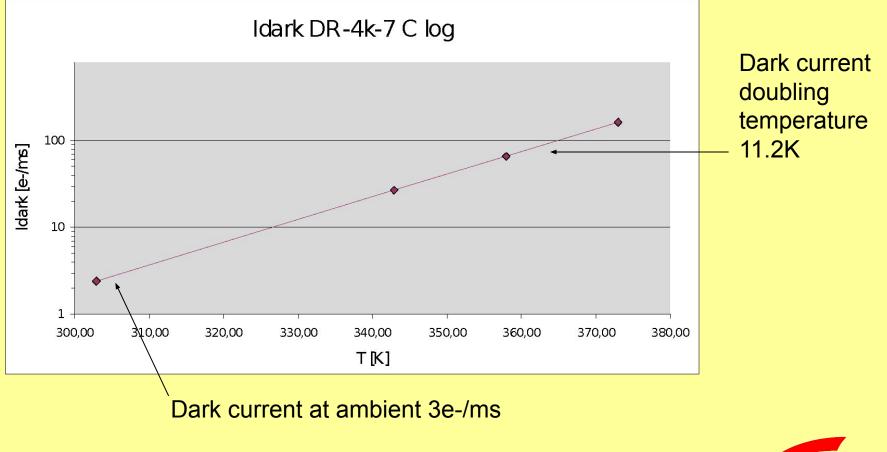
oReport the increase of variance versus integration time.

Subtract from each series the mean signal value and the variance value of the shortest integration time from each measurements point.
From the increase in variance compute the dark current in [e-/s] and the dark current doubling temperature [K]



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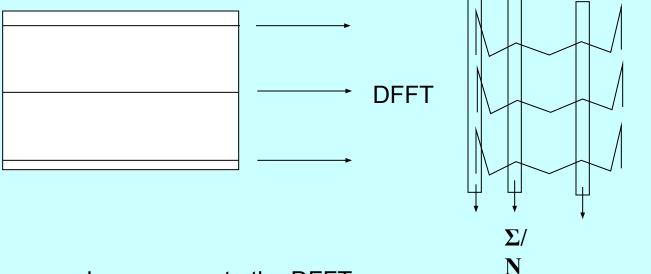


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#### Standard 1288 Module 1 11) Spectrogram



Idea: describe DSNU & PRNU effects in from of a spectral amplitude plot to Show high frequency (E.g. odd even mismatch) and low frequency (E.g. over all gradients) parts of spatial and temporal noise separately



•From each row compute the DFFT

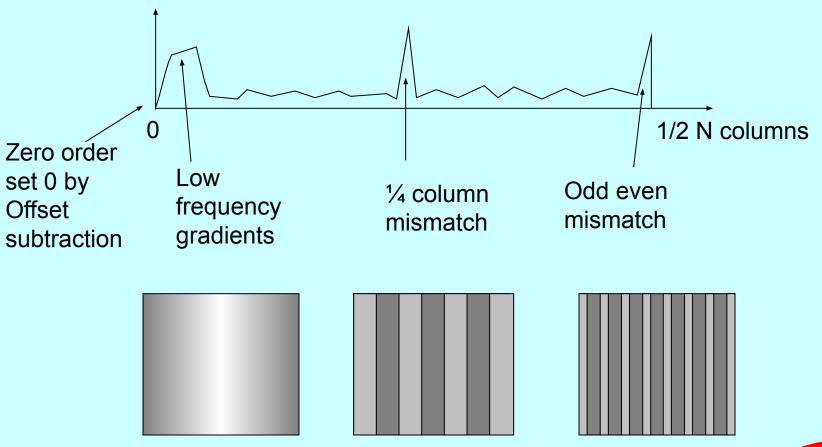
oAverage the FFT values along each column of the FFT result matrix
 oPlot the resulting spectrogram for Dark; 50% Saturation; 90% Saturation



#### Standard 1288 Module 1 12) Interpretation of Spectrogram



Interpretation:

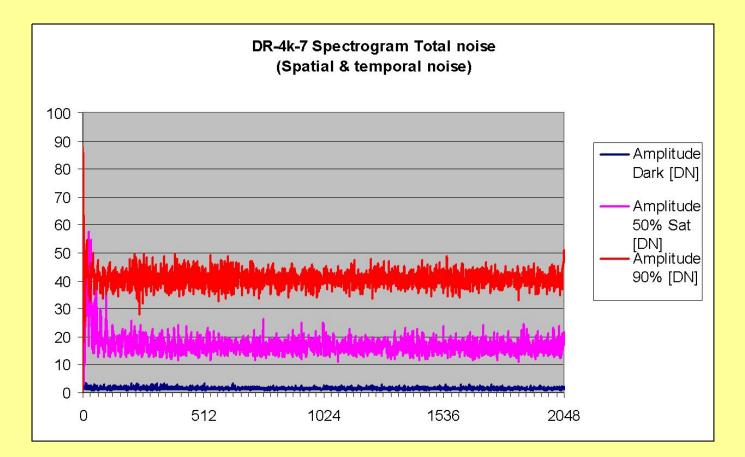




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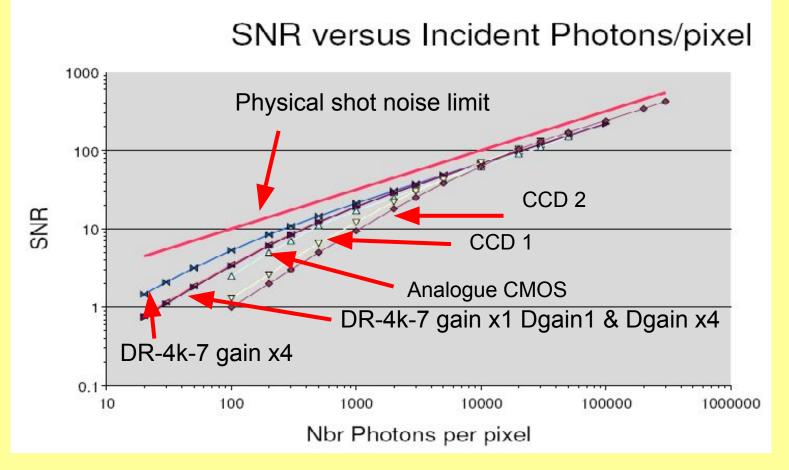






#### User Benefit 1288 Compare different Settings Objectively







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#### Optimize performance based on real values rather than visual impression!



TMAGE SENSORS

Raw sample image DR-4k-7 at previously described operation point



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## Thank you for your attention

• Current standard draft

<u>www.emva.org</u> www.emva.org or <u>www.standard1288.org</u> Contact EMVA:

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Contact me:

waeny@awaiba.com

# In God we trust, all other we measure

